E lectron Transport Through M olecules: Self-consistent and N on-self-consistent A pproaches

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A self-consistent m ethod for calculating electron transport through a molecular device is developed. It is based on density functional theory electronic structure calculations under periodic boundary conditions and im plem ented in the fram ework of the non-equilibrium G meen function approach. To avoid the substantial computational cost in nding the I-V characteristic of large system s, we also develop an approxim ate but much more e cient non-self-consistent m ethod. Here the change in e ective potential in the device region caused by a bias is approxim ated by the main features of the voltage drop. As applications, the I-V curves of a carbon chain and an alum inum chain sandwiched between two alum inum electrodes are calculated { two systems in which the voltage drops very di erently. By comparing to the self-consistent results, we show that this non-self-consistent approach works well and can give quantitatively good results.

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I. IN TRODUCTION

In recent years, electron transport through molecules sandw iched between metallic electrodes has been attracting increasing attention both for fundamental reasons and because it may form the basis of a future molecular electronics technology.^{1,2,3,4,5} Experimentally, it is di – cult to precisely manipulate or even measure the atom ic structure of the molecule-electrode contacts. Therefore, neither the in uence of atom ic structure on transport through the devices nor a path to improved perform ance is clear. As a result, the ability to calculate the atom ic and electronic structure as well as the transport properties of electrode-molecule-electrode systems is in portant and useful in this eld.

Electron transport through nanoscale molecular devices di ers signi cantly from that through macroscopic sem iconductor heterostructures. In the latter, the e ective-m ass approxim ation is generally successful because of the periodic lattice structure and large electron wavelength. In contrast, in a molecular device a carrier electron will be scattered by only a few atoms whose particular arrangement, then, matters a great deal. Consequently, the e ective-mass approximation breaks down, and the electronic structure of the molecular device must be taken into account explicitly. For this purpose, m ethods based on density functional theory (DFT) are su ciently accurate and e cient.^{6,7} Conventional DFT methods, however, deal with either closed molecular systems (in quantum chemistry) or periodic solids (in solid state physics), neither of which is applicable to molecular transport. Thus one needs to develop a DFT approach suitable for a system which is open, in nite, non-periodic, and non-equilibrium (if the bias voltage is nonzero).

O neway to do this was suggested by Lang, et al.^{8,9,10,11} By using the jellium model for the two metallic electrodes of an electrode-molecule-electrode system, they m apped the K ohn-Sham equation of the system into the Lippm ann-Schwinger scattering equation and solved for the scattering states self-consistently. They then calculated the current by summing up the contributions from all the scattering states, following a Landauer-type approach.¹² In this way, both the conductance and I-V characteristics of the system can be investigated. The use of the jellium m odel for electrodes is convenient and sim – ple but limited: it cannot include the e ects of di erent contact geometries and surface relaxation, for instance. It also cannot deal with directional bonding such as in sem iconductors and transition m etals. As a result, the m olecule-electrode charge transfer, which is one of the key factors a ecting transport, m ay not be quantitatively correct.¹³

Another way to develop the desired DFT approach is to use the non-equilibrium Green function (NEGF) m ethod.^{14,15} The required open and non-equilibrium conditions can be treated rigorously, at least in a form al sense. This method is also closely related to the Landaur approach¹² and has proven to be pow erful for studying electron transport through nanoscale devices. Therefore, by combining the NEGF method with conventional DFT-based electronic structure methods used in quantum chem istry or solid-state physics, the coherent transport properties of an electrode-molecule-electrode system can be determined fully self-consistently from rstprinciples. A further advantage of the NEGF+DFT com bination is that the atom ic structure of the device region and the m etallic electrodes are treated explicitly on the sam e footing. As has been mentioned, the moleculeelectrode interaction will induce charge transfer between them and atom ic relaxation of their contact { both have a signi cant e ect on electron transport. As a result, the division of the system into the molecule and the electrodes is not m eaningful anym ore, and som e parts of the electrodesm ust be included into the device region to form an \extended m olecule".

B ased on this combined NEGF+DFT method, there are several successful in plan entations^{16,17,18,19,20} for molecular conduction and extensive theoretical results in the recent literature.^{16,17,18,19,20,21,22,23} A coording to the way of treating the extended molecule, the sem i-in nite leads, and their couplings in a lead-molecule-lead (LML) system, these in plan entations can be roughly divided into two categories.

In one category people adopted a cluster geometry for all the subsystem s of a LM L system or for the extended molecule with the leads treated by a tight binding approach (for example, Ref. 16,23,24). It is then convenient to employ well-established quantum chem istry code (like Gaussian or DM ol) to do the electronic structure calculation for the subsystem (s). However, there are potential problem swith these treatments for strong molecule-lead couplings: in this case it is obviously necessary to included large parts of the leads into the extended m olecule so that the strong m olecule-lead interaction can be fully accommodated. To eliminate the articially introduced surface e ects an even larger system is needed, which is usually dicult to deal with by a quantum chemistry code. So in practice only several (or even only one) lead atom s are attached to the molecule to form an extended molecule (for example, Ref. 23,24). In this case, significant arti cial surface e ects are inevitable, the contact atom ic relaxation cannot be included, and an accurate m olecule-lead coupling is not available. In addition, there may be articial scattering at the interface between the tight-binding part of the lead and the DFT part of the lead (included in the extended molecule).

In the other category (Ref.18,19), people adopted periodic boundary conditions (PBC) (as in solid state physics) with large parts of the leads included in the extended molecule, so that the interaction between the molecule and its im ages will be screened o by the metallic lead in between. In this case all the potential problems mentioned above will be absent and the whole LM L system becomes nearly perfect in geometry and all the subsystem s are treated exactly on the same footing. Two examples of successful implementations adopting the PBC are the TranSiesta package¹⁸ and the MCD-CAL package.¹⁹ On the other hand, a draw back is introduced by PBC: when a bias is applied, the Hartree potential must jump unphysically between unit cells. This has previously been addressed by having an independent solution of the Poisson equation.

In this paper, we rst develop a fully self-consistent NEGF+DFT method with PBC, which has small but important di erences from the two previous implementations. The advantage of our method is that it is simple while still rigorous: the non-equilibrium condition under a bias is fully included in the NEGF part, and, as a result, we do not need to make changes in the conventional electronic structure part. So it is straightforward to com bine with any electronic structurem ethod that uses a localized basis set. M ore importantly, in this way the problem of the unphysical jumps in the Hartree potential is avoided. 2

A shortcoming of the full self-consistent (SC) NEGF+DFT approach is the large computationale ort involved, especially for large systems, large bias voltages, or cases where m any bias voltages need to be calculated as for I-V characteristics. As a result, a non-self-consistent (non-SC) m ethod with m uch higher e ciency and useful accuracy is highly desirable. As a step toward this goal, we also construct an approximate but m uch m ore e cient non-SC m ethod in which the change in self-consistent e ective potential in the device region caused by a bias is approximated by the m ain features of the voltage drop.

As an application of our approach, in this paper we do calculations by combining it with a very e cient electronic structure package SESTA.²⁶ The I-V curves of two systems with di erent typical voltage drop behaviors { a carbon or alum inum chain sandwiched between two alum inum electrodes { are calculated. Our self-consistent results are in good agreement with those from previous calculations.^{18,32} By comparison to the self-consistent results, we exam ine the validity of the non-SC approach, showing that this approach works quite welland can give quantitatively nearly correct answers.

The arrangement of this paper is as follows. In Section II we give brie y a description of our in plementation of the NEGF+DFT method. Because the basic form alism of the NEGF+DFT is well established, 16,17,18,19 we show only those formula useful for introducing the new features of our method. The present SC and non-SC approaches are explained in Section III. Section IV starts with results for a carbon chain and an alum inum chain sandw iched between two A 1(001) electrodes. Our results are compared with previous results, and we discuss the validity of the non-SC approach by comparison to the self-consistent results. In Section V we summarize and conclude.

II. NEGF+DFT METHOD AND ITS IM PLEMENTATION

A. M odeling of real physical system s

Experimentally, a molecular device system consists of at least a molecular junction coupled with two metallic electrodes (leads L and R) under a bias V_b (two-term inal system). In some cases, there is also a gate term inal applying a gate voltage on the whole system (three-term inal system). Here we consider only the two-term inal system which is schematically shown in Fig. 1. An important consideration form odeling the realphysical system is the charge transfer and atom ic relaxation around the two molecule-lead contact regions. As a result, we have to include some parts of the metallic leads into the device region, form ing an extended molecule. One obvious convergence criteria for the size of the extended molecule is its charge neutrality. Then the charge transfer and the potential disturbance caused by the molecule can be considered screened o outside the extended molecule region. In order to obtain good convergence, we actually include a large part of each m etallic lead into the C region, so that the layers adjacent to L and R (i.e., C_L and C_R parts in Fig. 1) have bulk properties. The total H am iltonian of the system is:

$$\hat{H} = \hat{H}_{LL} + \hat{H}_{CC} + \hat{H}_{RR} + \hat{H}_{LC} + \hat{H}_{CR} :$$
(1)

N ote that, here the leads L and R interact only through the molecular junction, so their direct interaction term \hat{H}_{LR} vanishes (this can always be satis ed by using a localized basis set).

B. Localized basis set

When \hat{H} is expanded in a basis set, generally only the matrix of \hat{H}_{CC} (denoted H_{CC}) is nite. However, consider a localized (but not necessarily orthogonal) basis set, by which we mean that the overlap between any two basis functions, (r R_1) and (r R_2), will be zero if they are separated far enough from each other: S h j i = 0 if $R_1 R_2 j$ > certain cuto distance. In this case, the region C interacts directly only with

nite parts of L and R, and the non-zero part of the m atrices H $_{LC}$ and H $_{CR}$ also become nite. Furtherm ore, we can divide the leads L and R into principal layers so that any principal layer interacts only with its two nearest neighbors (see Fig. 1). As a result, the matrices H $_{LL}$

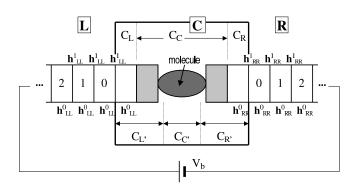


FIG.1: Schem atic drawing of a system containing a molecule sandwiched between two metallic electrodes (leads L and R). The region C is formed by including some parts of L and R so that the C_c part (extended molecule) is charge neutral and the C_L and C_R parts have bulk properties. Because of the use of a localized basis set, the leads L and R can be divided into principal layers (denoted by numbers 0, 1, 2, ...). C_Lo, C_Co, and C_Ro denote the parts used in the present non-SC approach (see Section IIE). Their interface is called X in the text. h⁰'s and h¹'s are the H am iltonian matrices within and between the principal layers, respectively.

and H $_{\rm RR}$ have the following block tridiagonal form :

$$(H_{LL})_{ij} = \begin{cases} 8 & h_{LL}^{0}; & \text{ifi} \quad j = 0 \\ & h_{LL}^{1}; & \text{ifi} \quad j = 1 \\ & & (h_{LL}^{1})^{y}; & \text{ifj} \quad i = 1 \\ & & & 0; & \text{ifji} \quad j > 1; \end{cases}$$
(2)

where h_{LL}^0 and h_{LL}^1 are the H am iltonian matrices within and between the principal layers, respectively, and i, j are principal layer indexes as shown in Fig. 1. Because the C_L and C_R parts which interact directly with L and R, have bulk properties, the non-zero part of H_{LC} (H_{CR}) is just h_{LL}^1 (h_{RR}^2), as shown in Fig. 1.

In the localized basis and after the partition shown in Fig. 1, the matrix G reen function G of the whole system, de ned by (ES H)G (E) = I, satis es

The most important part of G is G_{CC} , corresponding to the region C; from the above equation,

$$G_{CC}(E) = fES_{CC} [H_{CC} + L(E) + R(E)]g^{1};$$
(4)

where $_{L}(E)$ and $_{R}(E)$ are self-energies which incorporate the e ect of the two sem i-in nite leads L and R, respectively. $_{L}(E)$, for example, is de ned by

$$_{\rm L}$$
 (E) = (ES_{LC} H_{LC})^YG⁰_{LL} (E) (ES_{LC} H_{LC}) (5)

where G_{LL}^{0} is the retarded G reen function of the left sem i-in nite lead. The latter is given in turn by

$$G_{LL}^{0}(E) = (zS_{LL} H_{LL})^{1};$$
 (6)
 $z = E + i;$

where a typical value for the lifetime broadening is about 1 meV.

Because of the localized basis set, the non-zero part of $S_{\rm LC}$, H $_{\rm LC}$, $S_{\rm CR}$, and H $_{\rm CR}$ become nite (being $\frac{1}{2}_{\rm L}$, $h_{\rm LL}^1$, $s_{\rm RR}^1$, and $h_{\rm RR}^1$). As a result, only the part of G $_{\rm LL}^0$ and G $_{\rm RR}^0$ corresponding to the 0th principal layer of the two leads (denoted $g_{\rm LL}^0$ and $g_{\rm RR}^0$) are needed for calculating the non-zero part of the self-energies:

$$_{L}$$
 (E) = E s_{LL}^{1} h_{LL}^{1} y_{LL}^{9} (E) E s_{LL}^{1} h_{LL}^{1} : (7)

O ur notation here follows that for the H am iltonian: s and g are submatrices of the corresponding upper case matrices. g_{LL}^0 and g_{RR}^0 are simply the surface G reen

functions of the two sem i-in nite leads. $q_{\rm L}$, for example, can be calculated either by simple block recursion,

$$g_{LL}^{0} (E) = z s_{LL}^{0} \quad h_{LL}^{0}$$
(8)
$$z s_{LL}^{1} \quad h_{LL}^{1} \quad {}^{y} g_{LL}^{0} (E) \quad z s_{LL}^{1} \quad h_{LL}^{1} \quad {}^{1};$$

or by a renorm alization m ethod²⁷ in terms of s_{LL}^0 , s_{LL}^1 , h_{LL}^0 , and h_{LL}^1 which can be determ ined by separate DFT calculations for the two leads. For sm all lifetime broadening (1 meV), we not that the renorm alization m ethod is much faster than simple block recursion. This is natural since n renorm alization interations incorporate 2^n principal layers, while n recursions incorporate only n.

From G $_{CC}$ (E), the projected density of states (PDOS) on the molecule (indicated by m) is given by

$$N_{m}(E) = -\frac{1}{2} \operatorname{Im} fTr_{m} [G_{CC}(E + i) \ S_{C}]g; \quad (9)$$

where Tr_m means the trace is performed only on the molecular part of the matrix.

C. Current

The Non-Equilibrium G reen Function technique $(N \in G F)^{15,15,28,29}$ provides a convenient way to calculate the current by post-processing a DFT calculation. The result is quite natural and intuitive: F irst, the basic assumption is that there is no energy relaxation within the m olecular region. Then, following a Landauer-like point of view, 12,15 one divides the electrons in the m olecule into two sets using scattering-wave states, those that cam e from the left lead and those that cam e from the right. The left-lead states are, of course, led up to the chem – ical potential in the left lead, L, while the right-lead states are led up to R. In equilibrium, the two chem – ical potentials are equal, and the current carried by the

left-lead states is, of course, equal to that carried by the right-lead states. As a bias is applied, the balance between the two types of states is disrupted and current ows. As di erent states are populated because of the change in chem ical potentials, the charge density in the m olecule also changes. The potential pro le must be solved for self-consistently in order to get an accurate m easure of the transm ission. It is this self-consistency which is the tim e-consum ing part of the calculation.

The expression for the steady-state current through the C region for applied bias $V_{\rm b}$ is

$$I(V_{b}) = \frac{2e^{2}}{h} \int_{-1}^{Z_{+1}} T(E;V_{b}) [f(E_{L}) f(E_{R})] dE;$$
(10)

where $_{\rm L}$ and $_{\rm R}$ are the chemical potentials, f is the Ferm i function, and T (E;V_b) is the transmission probability for electrons from the left lead to right lead with energy E under bias V_b. The transmission probability is related to G reen functions by

$$\begin{array}{c} h & i \\ \texttt{T} (\texttt{E} ; \texttt{V}_{\texttt{b}}) = \texttt{Tr}_{\texttt{L}} (\texttt{E})\texttt{G}_{\texttt{CC}} (\texttt{E})_{\texttt{R}} (\texttt{E})\texttt{G}_{\texttt{CC}}^{\texttt{Y}} (\texttt{E}) ; (11) \end{array}$$

where

$$L_{R}(E) = i L_{R}(E) [L_{R}(E)]^{\vee}$$
 (12)

re ect the coupling at energy E between the C region and the leads L and R, respectively.

The charge density corresponding to the above picture of left-lead states led to $_{\rm L}$ and right-lead states led $_{\rm R}$ can also be expressed in term s of G reen functions. In particular, the density matrix of region C in the basis-function space is

$$D_{CC} = \frac{1}{2} \int_{-1}^{Z_{+1}} dE G_{CC}(E) L(E) G_{CC}^{Y}(E) f(E) L(E) - G_{CC}^{Y}(E) f(E) L(E) - G_{CC}^{Y}(E) - G_{CC$$

T in e-reversal sym m etry (G $_{CC}^{\gamma}$ = G $_{CC}$) was invoked in going from (13) to (14). The integrand of the rst term of (14) is analytic (all poles of G $_{CC}$ (E) are on realaxis), so the integral can be evaluated easily by complex contour integration. However, the integrand of the second term is not analytic, so it must be evaluated by integrating very

cbse to the realaxis using a very ne energy mesh. The whole integration path¹⁷ is shown in Fig. 2. Because we construct the region C such that C_L and C_R have essentially bulk properties, we can use the bulk density matrix for them.

The calculated density matrix is then output to the

DFT part to calculate the electron density and to construct a new H $_{CC}$:

$$(r) = (r)Re(D_{CC}) (r); (15)$$

$$(H_{CC}) = \hat{T} + \hat{V}_{ext}(r) + \hat{V}_{H}[(r)] + \hat{V}_{xC}[(r)] ;$$
(16)

where \hat{T} is the kinetic energy, and \hat{V}_{ext} , \hat{V}_{H} , and \hat{V}_{xc} are the external, Hartree, and exchange-correlation potential energies, respectively. The new H_{CC} replaces the old, a new D_{CC} is calculated, and so on until H_{CC} or D_{CC} converges. Finally, the transmission function T (E) can be calculated by Eq. (11).

One subtlety here is the di erent boundary conditions used in the G reen function and DFT parts { open versus periodic, respectively. This means that some iteration must be done even at $V_b = 0$. If the supercell of the DFT part has the same size as region C in Fig. 1, then the C_{L} and C_{R} parts will interact directly due to the periodic boundary condition. However, this interaction is absent in the calculation of the density matrix. The same problem exists also for H_{CC}. So we need to do some translation work between the Green function and DFT parts: to add this interaction when we go from NEGF to DFT by using the density matrix elements between two adjacent principal layers, and to remove it when we go from DFT to NEGF by setting corresponding parts of S_{CC} and H_{CC} to zero. Generally, the supercell of the DFT part can be made larger than the size of the region C, especially for system s without a translational sym m etry, because the DFT part is usually m uch cheaper than the G reen function part.

> Im[z] Re[z] μ_{I} μ_R E_{B}

FIG. 2: Schematic drawing of the integration path in the complex energy plane used to calculate the density matrix [Eq. (14)]. E_B is the lowest energy of occupied states, and $_{\rm L\,;R}$ are the chem ical potentials of the left and right leads, respectively ($_{\rm L}$ < $_{\rm R}$ is assumed). Note that for energy window [E $_{\rm B}$, $_{\rm L}$] a complex contour integration is perform ed while for energy window $\ensuremath{\left[\begin{array}{c} {}_{L} \end{array}\right]}$ a direct energy integration is performed by using a ne energy mesh and a very small im aginary part.

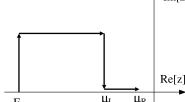
III. NEW SELF-CONSISTENT AND NON-SELF-CONSISTENT APPROACHES

A. Bias voltage

For non-zero $V_{\rm b}$, care m ust be taken to account for the e ects of the bias voltage on the charge density. One way to proceed is to apply a constant eld in the direction parallel to the leads within the supercell of the DFT calculation. Thus a linear drop is added to the external potential in Eq. (16), and the e ect on the charge density follows from, for instance, solving the Poisson equation. This approach is not straightforw and for periodic boundary conditions because of the arti cial potential jum ps at the two supercell boundaries in the lead direction. One way to elim inate the unphysical jumps is to use a larger supercell for the DFT calculation and replace the Ham iltonian of each of the regions near the potential jumps by the bulk one with a constant potential shift given by the bias voltage; this is in plemented in the Transiesta program .18

Here we propose a di erent approach to handle the bias, one which is less obvious but turns out to be sim pler in the end: The bias is included through the density m atrix (D $_{\rm C\ C}$) in the G reen function calculation instead of the potential (H_{CC}) in the DFT part. Speci cally, we calculate the density matrix by Eq. (13) under the boundary condition that there is a potential di erence V_{0} between part $C_{\rm L}$ (together with the left lead) and part C_R (together with the right lead). This is done by shifting all the potentials related to the left (right) lead and the C_L (C_R) part by $V_b=2$ (+ $V_b=2$). Shifting the potential in a lead is equivalent to directly shifting the energy by the opposite am ount, so





$$D_{CC} = \frac{1}{2} \int_{1}^{2} dE \quad G_{CC}(E) = \frac{eV_b}{2} G_{CC}(E) f(E) = \int_{1}^{2} (E + \frac{eV_b}{2}) G_{CC}(E)$$

Here the G reen function G _{C C} (E) has all the potential shifts included,

$$G_{CC}(E) = E S_{CC} + H_{CL} + H_{CR} + L(E + \frac{eV_b}{2}) + R(E - \frac{eV_b}{2}) ;$$
(18)

where the $C_{\rm L}$ and $C_{\rm R}\,$ parts of H $_{C\,C}\,$ are replaced by $h^0_{L\,L}$ and $h^0_{R\,R}$, and their potential shifts are

$$[H_{C_{L}}] = \frac{eV_{b}}{2} [S_{CC}] ; 8 ; 2 C_{L};$$
 (19)

$$[H_{C_R}] = + \frac{eV_b}{2} [S_{CC}]$$
; 8; 2 C_R : (20)

The actual computational process is exactly the same as that of (14) and Fig. 2, and self-consistency is achieved in the same way as for zero bias. Finally, in the calculation of the transm ission, the potential shift present in the self-energies appears in $_{\rm L,R}$ as in (17),

$$T (E; V_{b}) = Tr_{L} (E + \frac{eV_{b}}{2})G_{CC} (E)_{R} (E - \frac{eV_{b}}{2})G_{CC}^{Y} (E)$$
(21)

W hile the two approaches mentioned here { the linear external potential and the potential shift in the leads { give quite di erent results in the unphysical noninteracting lim it, self-consistency ensures that they give the same result in physical cases. Our approach has the distinct technical advantage that the G reen function and DFT calculations are com pletely disconnected, allowing the transport module to be easily com bined with a wide variety of electronic structure codes.

B. A pproxim ate non-self-consistent approaches

For large systems under large bias, the full SC approach described above is computationally very di cult. The longest part of a one-time calculation is noting the surface G meen functions (for all the points in the energy m esh), even with the fast renorm alization m ethod. How – ever, one only needs to do these calculations once and save the results. The major cost for a full self-consistent calculation is from noting G_{CC} (E) by Eq. (4) at the many energies needed for the density matrix, especially for the very nemesh in the energy window [L, R] (see Fig. 2).

To avoid the complex procedure and large computational e ort of full self-consistency, here we propose an approximate non-SC approach in which the bias is included by (a) applying a potential shift $eV_b=2$ (+ $eV_b=2$) to the left (right) lead through the self-energies as in Eq. (21), and (b) introducing potential shifts non-selfconsistently into the region C. The main consideration is that it may be a good approximation to replace the change in self-consistent e ective potential caused by a bias by the main features of the voltage drop. This assumes, of course, that one can guess orm otivate the main features in advance. For instance, for conductive molecular devices, the bias voltage will drop mainly at the left and right contact regions if the contacts have low transparency or over the whole molecular region if the contacts are very transparent.

In our approach, we introduce new parts on the left $(C_{L^{0}})$ and right $(C_{R^{0}})$ within the region C which extend o from their respective leads to the molecular contacts, as j shown in Fig. 1. We will denote by X the interface between the molecule $C_{C^{0}}$ and the regions $C_{L^{0}}$ plus $C_{R^{0}}$. If the voltage drop around the left (right) contact is V_{b} $((1)V_{b})$, then the potential shifts are applied in the following way (which we call the H 1 treatment):

$$H_{CC}^{\circ} = H_{CC} + \frac{1}{2} eV_b S_{CC};$$
 (22)

Because the potential shift is applied to a matrix element
when either orbital index is in the
$$C_{L^0;R^0}$$
 part, the voltage
drop will be slightly smeared around the interface X. To
explicitly show the role of S_{CC} in (23) and (24), we also
drop the potential using (called the H0 treatment)

$$H_{C_{L}^{0}} = e V_{b} [S_{CC}] ; ; 2 C_{L^{0}};$$
 (25)

$$H_{C_R^0} = e(1) V_b[S_{CC}]$$
; ; 2 C_{R^0} : (26)

In either case, G $_{\rm C\,C}$ (E) is determined by an equation analogous to Eq. (18) in the SC case,

$$G_{CC}(E) = E S_{CC} \qquad H_{CC}^{\circ} + H_{C_{L}^{\circ}} + H_{C_{R}^{\circ}} (27)$$
$$+ {}_{L}(E + \frac{eV_{b}}{2}) + {}_{R}(E - \frac{eV_{b}}{2}) \qquad 1$$

The initial H $_{\rm CC}$ m atrix here com es from a separate DFT calculation using a large L-C-R supercell. Finally, the current is calculated as usual through Eqs. (21) and (10).

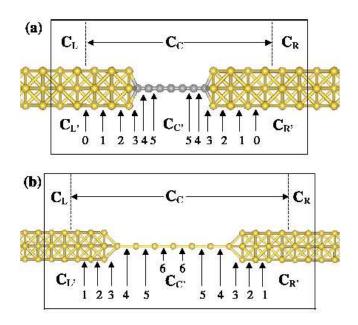


FIG. 3: (Color online) System s calculated: (a) a chain of 7 carbon atom s sandwiched between two Alleads in the (001) direction of bulk Al, (b) a chain of 7 Allatom s sandwiched between the same leads. The C-Aldistance in (a) is 1A and the C-C distance is 1.323A. The AlAl (chain) distance in (b) is 2.86A and the AlAl(surface) distance is 2.025A (i.e., the two Allatom s at the ends of the chain are in their bulk positions). The notations for di erent parts are the same as in Fig. 1. The numbers 0, 1, 2, 3, 4, 5, 6 denote di erent interfaces, called the interface X, between C_L or C_R and C_C which are used in the present non-self-consistent approach.

So far we have considered the simplest case of low transparency contacts so that the voltage drops in only two places near the contacts. In this simplest case the

param eter here has the sam e role as the param eter in Ref. 25. For a real device, the voltage drop may be much more complicated, and there may be several different voltage drops inside the device region. However, in our method all the factors a ecting the voltage drop have been taken into account at the DFT level, and it is straightforward to generalize the present non-SC approach for these m ore complicated situations (see calculations for system B in Section IV) as long as the main features of the voltage drop are known. A ctually, we will show later that results of this non-SC approach are not very sensitive to the choice of the voltage drop. If we assume that the form of the drop is not a ected significantly by a change in the bias voltage itself, then the main features of the voltage drop in a system can be determ ined by a single self-consistent calculation using a relatively sm all bias voltage.

IV. APPLICATIONS:CHAINS OF CARBON OR ALUM IN UM

We report calculations of I-V curves for two systems: a carbon chain (system A) or an alum inum chain (system B) sandwiched between two alum inum leads in the (001)direction of bulk Al. The structures are shown in Fig. 3. No further atom ic relaxation is performed for simplicity and for direct comparison with previous results.

Our implementation of the transmission calculation is independent of the DFT part. Therefore, it can be easily combined with any DFT package that uses a localized basis set. As an application, here we combine it with the very e cient full DFT package SIE STA,²⁶ which adopts a LCAO -like and nite-range num erical basis set and makes use of pseudopotentials for atom ic cores. In our calculations we adopt a single zeta (SZ) basis set. To check the convergence of the results, we also calculate the equilibrium transmission function using a single zeta plus polarization (SZP) basis set. The di erence is found to be m inor. The PBE version of the generalized gradient approximation³⁰ is adopted for the electron exchange and correlation, and optim ized Troullier-M artins pseudopotentials³¹ are used for the atom ic cores. The initial density matrix of the region C is obtained from a separate DFT calculation using a large L-C-R supercell.

There are two main reasons for us to choose to study these systems. First, the transmission function T (E) of system A has been calculated by both the TranSiesta¹⁸ and MCDCAL³² packages using a SZ basis set. So we can make a direct comparison to previous results. Second, system s A and B typify two di erent voltage drop behaviors (although both the C and Alchains are conductive). In system A, because the molecule-lead contact is a hetero-interface, the voltage drop will mainly occur around the two interfaces [see Fig. 4 (a), note that the voltage drops around the two interfaces are actually asymmetric]. In contrast, in system B the molecule-lead contact is a hom o-interface, and furtherm ore the two Al atoms at the ends of the chain are at their bulk positions. So the voltage drop will occur over the entire Al chain in som e way [see Fig. 4 (b)]. Our purpose is to see whether our non-SC approach can handle these di erent conditions.

A. Transm ission functions

In Fig. 5 we show the calculated transmission functions and PDOS (projected on the chains) for system A and B under zero bias voltage. As it can be seen, the transmission function generally follows the PDOS except for some localized states (for instance, around 4 5 eV in (a) and 1 eV in (b)) which are not coupled with the left or the right lead. Our result of T (E) for system A is in very good agreement with the previous results from Transiesta and MCDCAL packages^{18,32} (see Fig. 6 (a) of Ref. 18).

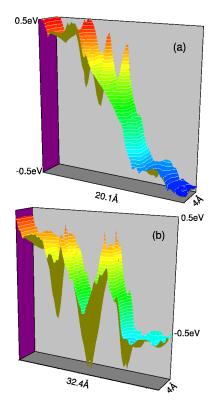


FIG.4: (C olor online) Voltage drop in a plane going through the atom ic chain for the C_c region of (a) the C chain and (b) the Alchain, as shown in Fig. 3, for an applied bias of -1 V. N ote that (1) in (a) the voltage drop mainly occurs around the right contact region while in (b) it occurs over the entire chain, and (2) the oscillation in (b) is much larger than that in (a). This is because the electrons in the Alchain are more free than that in the C chain; as a result, the polarization induced by the bias is larger in the Alchain.

In Fig. 6 we show, for system A under a bias of 1.0V (=0.5), the calculated T (E) by the SC approach and the non-SC approach (H1 treatment) with di erent choices for the interface X between the C_{L^0} or C_{R^0} and $C_{C^{0}}$ parts. The set thing we note is that our SC result for 1V bias is in very good agreem ent with the previous self-consistent results^{18,32} (see Fig. 6 of Ref. 18). W hen we change the interface X (denoted by the di erent numbers in Fig. 6) from deep in the leads to the contact regions (i.e., interface X = 1 ! 2 ! 3), the non-SC result varies signi cantly. How ever, as X moves into the contact regions (i.e., interface X = 3, or 4, or 5), the result becomes very close to the SC result and insensitive to the exact position of X . This result is just what we expect because in system A the bias voltage drops m ainly around the hetero-interface contact regions. This can be regarded as an advantage of the present non-SC approach its result is not strongly dependent on the technical choice.

Sim ilar calculations of T (E) for system B under $V_b = 1.0V$ (= 0.5, H 1 treatm ent for non-SC) are shown in Fig. 7. Again, after the interface X is moved into the contact regions the di erent non-SC result become quite

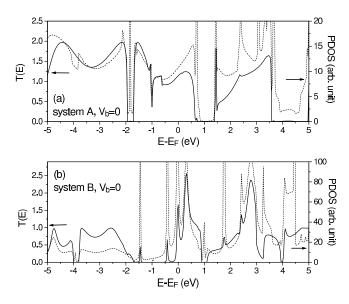


FIG.5: Calculated transmission function T(E) (solid line) and projected density of states (PDOS, projected on the chains, dashed line) by the self-consistent approach for (a) the carbon chain (system A) and (b) the alum inum chain (system B) under zero bias voltage. When T(E) is signi cantly different from the PDOS, it means that a localized state exists at that energy.

close. However, compared to the case of system A, the agreement with the SC result is not good, especially in the energy range around the (averaged) Ferm i level: the transm ission from the non-SC calculations (except for interface X = 5) is noticeably larger than that from the SC calculation. This substantial disagreement originates in the di erence between the self-consistent elective potential [Fig. 4 (b)] and the non-self-consistent one assumed in the non-SC approach.

B. I-V curve of system A

In order to show e ects of di erent voltage drops and the di erence between the H0 and H1 treatments [see Eqs. (23)-(26)] for potential shifting, we give in Fig. 8 the calculated I-V curves for system A from the non-SC approach with interface X = 3 com pared to the SC result.We do the non-SC calculations for three di erent voltage drops (= 0.2, 0.5, 0.8) for the H 1 treatment. In addition, for = 0.8 we do the non-SC calculation with the HO treatment. Among the three di erent voltage drops, the result for = 0.2 is in poor agreem ent with the SC result while those for = 0.5 and 0.8 are in good agreem ent. This makes sense in view of the main features of the voltage drop in Fig. 4 (a): the bias voltage will mainly drop around the left (right) contact for a positive (negative) bias. However, the smalldi erence in I-V curve between = 0.5 and 0.8 indicates that the I-V characteristics is actually not sensitive to the exact change in voltage drop. By comparing the SC result and

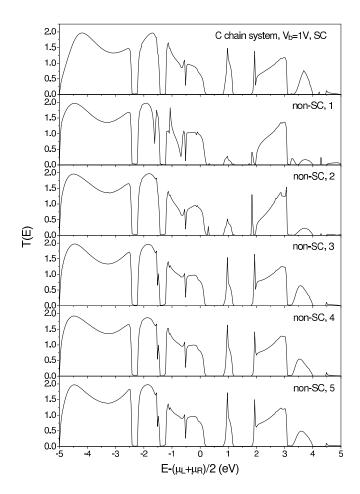


FIG.6: Transm ission function T (E) for the carbon chain (system A) under 1 V bias (= 0.5) from the SC approach and the non-SC approach (H 1 treatment) with di erent choices for the interface X between C_c $_{\circ}$ and the C_L $_{\circ}$ or C_R $_{\circ}$ parts (denoted by 1', ..., 5') as shown in Fig. 3 (a). Note the sim ilarity between the di erent non-SC results and the fully SC result once X is placed in the contact regions (3).

the two non-SC results for = 0.8, we see that the H 1 treatment improves the result markedly. This is understandable because voltage drops in real physical systems are not sharp step-functions but are somewhat smeared out.

C. I-V curves of system s A and B : com parison of di erent approaches

I-V curves for system sA and B calculated by di erent approaches are given in Figs. 9 and 10, respectively. For the non-SC approach, = 0.5 and the H 1 treatment are always adopted. It turns out that for sm allbias voltages ($V_{\rm b} < 0.3$ V) all the di erent treatments (the SC, the non-SC with di erent interface X), all give similar results, i.e., the e ect of the di erent voltage drops is very sm all. A long with the increase of bias voltage, the di erence am ong the di erent calculations becomes more

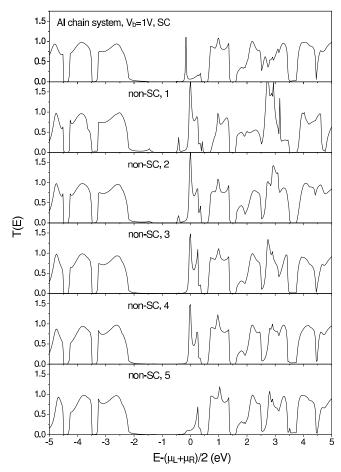


FIG. 7: Calculated transmission function T (E) for the Al chain system under $1 \vee bias$ (= 0.5, H1 treatment for non-SC) by the SC and non-SC approaches. The notations are similar to those in Fig. 6

and more signi cant.

For the carbon chain (system A), because them oleculeelectrode contact is a hetero-interface and therefore the voltage drop occurs mainly around the contact regions, the SC result and the non-SC results with the interface X located around the two contact regions are in good agreement. As for the transmission function in Fig. 6, once the interface X is within the contact regions the result is quite insensitive to the technical choice. This indicates that for system smade of conductive molecular junctions coupled with metallic electrodes through heterointerfaces, the present non-SC approach works quite well and can give nearly quantitatively correct answers.

For the alum inum chain (system B) the moleculeelectrode contact is a homo-interface and the two Al atoms at the ends of the chain are at their bulk positions; therefore, the voltage drop is not localized around the contact regions. Consequently, the result from the non-SC approach with the interface X located around the contact region is not in good agreem ent with the SC result. In order to further verify our analysis for system B, we generalize the present non-SC approach for a

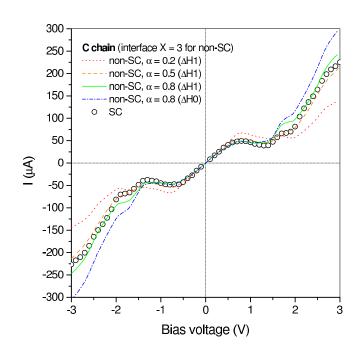


FIG.8: (Color online) Calculated I-V curves for the C chain system by the SC approach and the non-SC approach with interface X = 3 [as shown in Fig. 3 (a)]. Three di erent voltage drops are considered: = 0.2, 0.5, 0.8. The H 0 and H 1 treatments are adopted for = 0.8. The simple non-SC approach does very well using = 0.5 or 0.8 and the H 1 treatment.

voltage drip occurring at multiple points: W e use a com -

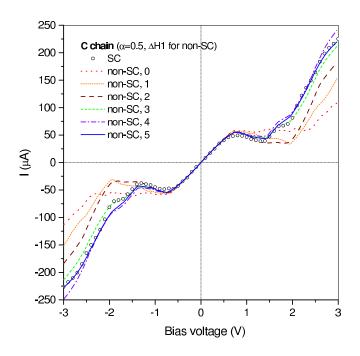


FIG.9: (Color online) Calculated I-V curves for the C chain system by the SC approach and the non-SC approach with di erent interface X indicated by the numbers. = 0.5 and H 1 treatment are adopted for the non-SC calculations.

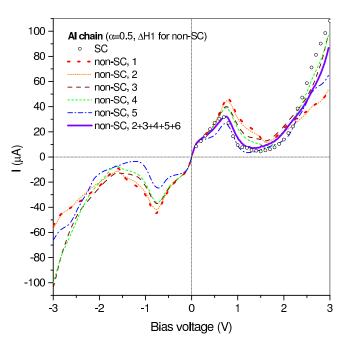


FIG.10: (Coloronline) Calculated I-V curves for the Alchain system by the SC and non-SC approaches. The notations are similar to those in Fig. 9. 2+3+4+5+6' m eans a combined interface X (see Fig. 3 (b)) and each interface bears 1/10 of a bias voltage (see Section IIIC).

bined interface X = 2+3+4+5+6 in which each layer bears a voltage drop of $V_b/10$. Because of the role played by the overlap m atrix in Eqs. (23) and (24), the resulting voltage drop w ill occur over the entire device region. The calculated I-V curve by the generalized non-SC approach is given in Fig. 10 by a violet solid line. The overall agreem ent with the SC result is remarkably in – proved, indicating that our analysis is reasonable.

D. Lim itation of the present approaches

For nishing the discussion we would like to point out the cases where the present m ethod will not work. O bviously, the present m ethod is only valid for steady state coherent electron transport through m etal-m olecule-m etal system s; there are basically two cases where our m ethod does not work: (1) electron transport in C oulom b blockade regime, for both the SC and non-SC approaches, and (2) cases where the main feature of voltage drop is sensitive to the value of the bias voltage itself, for the non-SC approach. In the st case, the contact barrier is so high that the molecule and the leads are essentially separated, and as a result, the molecular chemical potential is generally di erent from the Ferm ienergies of the leads even under zero bias. Because in our DFT + NEGF approach there is only one Ferm i energy under zero bias, it will fail in this case. The second case is just the opposite to that assumed in our non-SC approach. We don't know at this moment what system s will have this behavior or

whether such kind of system s exist. But this can be easily checked by doing selfconsistent calculations for several di erent bias voltages within the bias range interested.

V. SUMMARY

A full self-consistent DFT-electronic-structure-based G reen function method has been proposed and in plemented for electron transport from molecular devices. Our method is simple and straightforward while strict. The implementation is very independent of the DFT electronic structure part; it can be easily combined with any electronic structure package using a localized basis set. In an e ort to avoid the extremely burdensome computational cost for large systems or for I-V characteristic analysis, we developed an approximate non-selfconsistent approach in which the change in e ective po-

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tential caused by a bias in the device region of a system is approximated by the main features of the voltage drop.

As applications of our m ethods, we calculated the I–V curves for two di erent system s with di erent typical voltage drops: a carbon chain and a alum inum chain sandw iched between two alum inum electrodes. Our self-consistent results are in very good agreem ent with those from other calculations. For both systems the present non-SC approach can give results in good agreem ent with the self-consistent results, indicating that it is a good approxim atem ethod with high e ciency for I-V characteristic analysis³³ (m ore then one order of m agnitude faster for m oderate system s). It is straightforward to generalize this non-SC approach to dealw ith any kind of voltage drop situation.

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the long-time lim it depends only on the asymptotic shape of the one-particle e ective potential of TDDFT.Our numerical result from the non-SC approach is just consistent

with this theoretical nding.